

## FDZ2554PZ

Monolithic Common Drain P-Channel 2.5V Specified PowerTrench<sup>®</sup> BGA MOSFET

## **General Description**

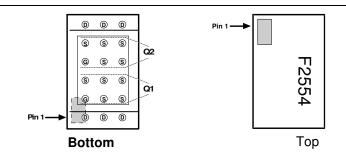
Combining Fairchild's advanced 2.5V specified PowerTrench process with state-of-the-art BGA packaging, the FDZ2554PZ minimizes both PCB space and  $R_{DS(ON)}$ . This monolithic common drain BGA MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, high current handling capability, ultra-low profile packaging, low gate charge, and low  $R_{DS(ON)}$ .

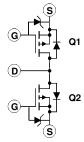
## **Applications**

- Battery management
- Load switch
- Battery protection

## Features

- -6.5 A, -20 V.  $R_{DS(ON)} = 28 \ m\Omega \ @ V_{GS} = -4.5 \ V$  $R_{DS(ON)} = 45 \ m\Omega \ @ V_{GS} = -2.5 \ V$
- >4800V ESD Protection
- Occupies only 0.10 cm<sup>2</sup> of PCB area: 1/3 the area of SO-8
- Ultra-thin package: less than 0.80 mm height when mounted to PCB
- Outstanding thermal transfer characteristics: significantly better than SO-8
- Ultra-low Q<sub>g</sub> x R<sub>DS(ON)</sub> figure-of-merit
- High power and current handling capability





## Absolute Maximum Ratings T<sub>A=25°C</sub> unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		-20	V
V <sub>GSS</sub>	Gate-Source Voltage		±12	V
ID	Drain Current – Continuous	(Note 1a)	-6.5	A
	– Pulsed		-20	
PD	Power Dissipation (Steady State)	(Note 1a)	2.1	W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C

## **Thermal Characteristics**

R <sub>eJA</sub>	Thermal Resistance, Junction-to-Ambient	(Note 1a)	60	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction-to-Ball	(Note 1b)	6.3	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	0.6	

## Package Marking and Ordering Information

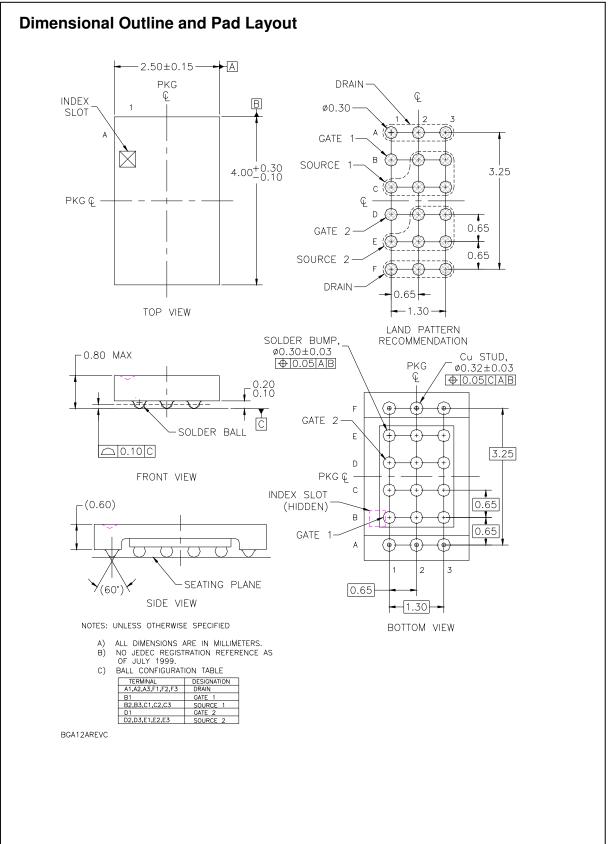
Device Marking	Device	Reel Size	Tape width	Quantity
2554Z	FDZ2554PZ	7"	12mm	3000 units

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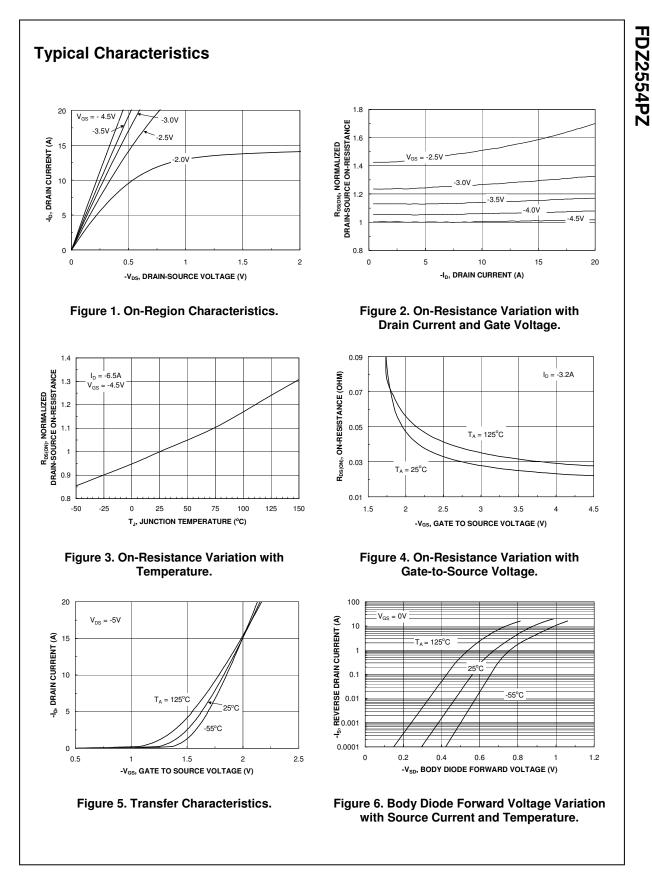
Off Chara	Parameter	Test Conditions	Min	Тур	Max	Units
JII Chara	cteristics	1				
BV <sub>DSS</sub>	Drain–Source Breakdown Voltage	$V_{GS} = 0 V, I_D = -250 \mu A$	-20			V
	Breakdown Voltage Temperature	$I_D = -250 \ \mu$ A, Referenced to 25°C		-13		mV/°C
$\Delta T_{\rm J}$	Coefficient					
DSS	Zero Gate Voltage Drain Current	$V_{DS} = -16 V, V_{GS} = 0 V$			-1	μΑ
GSS	Gate-Body Leakage	$V_{GS} = \pm 12 \text{ V},  V_{DS} = 0 \text{ V}$			±10	μA
	cteristics (Note 2)					
/ <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-0.6	-0.8	-1.5	V
VGS(th)	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \ \mu A$ , Referenced to 25°C		3		mV/°C
$\Delta T_J$ R <sub>DS(on)</sub>	Static Drain–Source	V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -6.5 A		21	28	mΩ
US(on)	On-Resistance	$V_{GS} = -2.5 V$ , $I_D = -5 A$		36	45	11152
		$V_{GS} = -4.5 \text{ V}, I_D = -6.5 \text{ A}, T_J = 125^{\circ}\text{C}$		30	43	
FS	Forward Transconductance	$V_{DS} = -5 V$ , $I_D = -6.5 A$		24		S
Dynamic	Characteristics					
liss	Input Capacitance	$V_{DS} = -10 V$ , $V_{GS} = 0 V$ ,		1430		pF
2 <sub>OSS</sub>	Output Capacitance	f = 1.0  MHz	<u> </u>	320		pF
Crss Crss	Reverse Transfer Capacitance	1		170		pF
R <sub>G</sub>	Gate Resistance	V <sub>GS</sub> = 15 mV, f = 1.0 MHz		9.2		Ω
-	g Characteristics (Note 2)			-		
d(on)	Turn-On Delay Time	$V_{DD} = -10 V$ , $I_D = -1 A$ ,		15	26	ns
a(on)	Turn-On Rise Time	$V_{\text{DD}} = -10$ V, $D_{\text{D}} = -1$ A, $V_{\text{GS}} = -4.5$ V, $R_{\text{GEN}} = 6 \Omega$		9	18	ns
	Turn-Off Delay Time			-	100	
d(off)	,	4		60		ns
ŕ	Turn–Off Fall Time			37	60	ns
ζ <sup>g</sup>	Total Gate Charge	$V_{DS} = -10 \text{ V}, \qquad I_D = -6.5 \text{ A}, \\ V_{GS} = -4.5 \text{ V}$		15	21	nC
⊋ <sub>gs</sub>	Gate-Source Charge	$v_{GS} = -4.5 v$		3		nC
Ĵ <sup>gd</sup>	Gate-Drain Charge			4		nC
Drain-So	urce Diode Characteristics	and Maximum Ratings				
S	Maximum Continuous Drain-Source				-1.75	Α
/ <sub>SD</sub>	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \ V, I_S = -1.75 \ A$ (Note 2)		-0.7	-1.2	V
r	Reverse Recovery Time	$I_{\rm F} = -6.5  {\rm A},$		25		ns
Q <sub>rr</sub>	Reverse Recovery Charge	d <sub>iF</sub> /d <sub>t</sub> = 100 A/μs		10		nC

FDZ2554P Rev C3 (W)

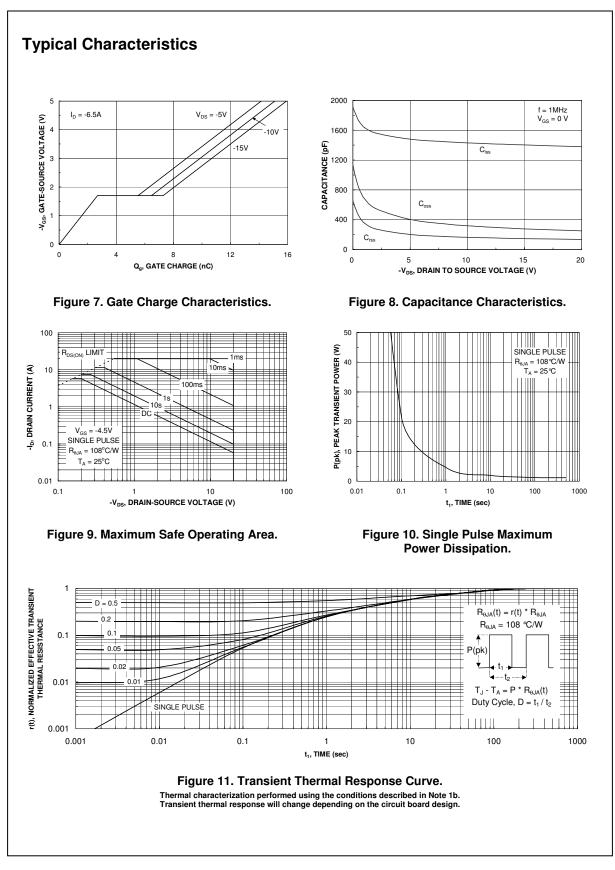
# FDZ2554PZ



FDZ2554PZ



FDZ2554P Rev C3 (W)



## FDZ2554PZ

FDZ2554P Rev C3 (W)

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